

Application/Control No.	Applicant(s)/Patent unde Reexamination	г
10/682,432	TEPPER ET AL.	
Examiner	Art Unit	
Ling-Siu Choi	1796	

SEARCHED					
Class	Subclass	Date	Examiner		
526	328	1/4/2008	LSC ·		
	318				
	310				
521	61				
	63				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
West .	1/4/2008	LSC
particle, molecular imprint, propellant, supercritical, template, monomer		
class/subclass search		
inventor search ,		
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